


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/711,633	BAKIR ET AL.	
	Examiner	Art Unit	
	Sun J. Lin	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	8	12/15/2005	JSL
716	9	12/15/2005	JSL
716	10	12/15/2005	JSL
716	2	12/15/2005	JSL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	12/15/2005	JSL